GD50MPS12H 1200V 50A SiC Schottky MPS™ Diode

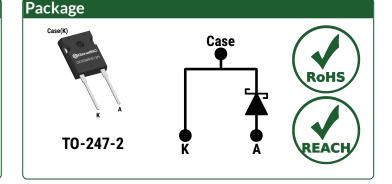
Silicon Carbide Schottky Diode



V _{RRM} =	1200 V
IF(Tc = 144°C) =	50 A
Qc =	162 nC

Features

- Gen4 Thin Chip Technology for Low VF
- Superior Figure of Merit Qc*VF
- 100% Avalanche (UIL) Tested
- Enhanced Surge Current Withstand Capability
- Temperature Independent Fast Switching
- Low Thermal Resistance
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- Electric Vehicles and Fast Chargers
- Solar Inverters
- Train Auxiliary Power Supplies
- High frequency Converters
- Motor Drives
- Induction Heating and Welding
- Uninterruptible Power Supplies
- Pulsed Power

Absolute Maximum Ratings (At T_c = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V _{RRM}		1200	٧	
		T _C = 100°C, D = 1	86		
Continuous Forward Current	IF	T _C = 135°C, D = 1	59	Α	Fig. 4
		T _C = 144°C, D = 1	50		
Non-Repetitive Peak Forward Surge Current, Half Sine	Isou	T _C = 25°C, t _P = 10 ms	400	Α	
Wave	IF,SM	T _C = 150°C, t _P = 10 ms	320	A	
Repetitive Peak Forward Surge Current, Half Sine Wave	lenu	T _C = 25°C, t _P = 10 ms	240	А	
	IF,RM	T _C = 150°C, t _P = 10 ms	168	A	
Non-Repetitive Peak Forward Surge Current	I _{F,MAX}	T_{C} = 25°C, t_{P} = 10 µs	2000	А	
i ² t Value	∫i²dt	T _C = 25°C, t _P = 10 ms	800	A ² s	
Non-Repetitive Avalanche Energy	E _{AS}	L = 0.4 mH, I _{AS} = 50 A	452	mJ	
Diode Ruggedness	dV/dt	$V_{R} = 0 \sim 960 V$	200	V/ns	
Power Dissipation	Ртот	T _C = 25°C	463	W	Fig. 3
Operating and Storage Temperature	Tj, Tstg		-55 to 175	°C	



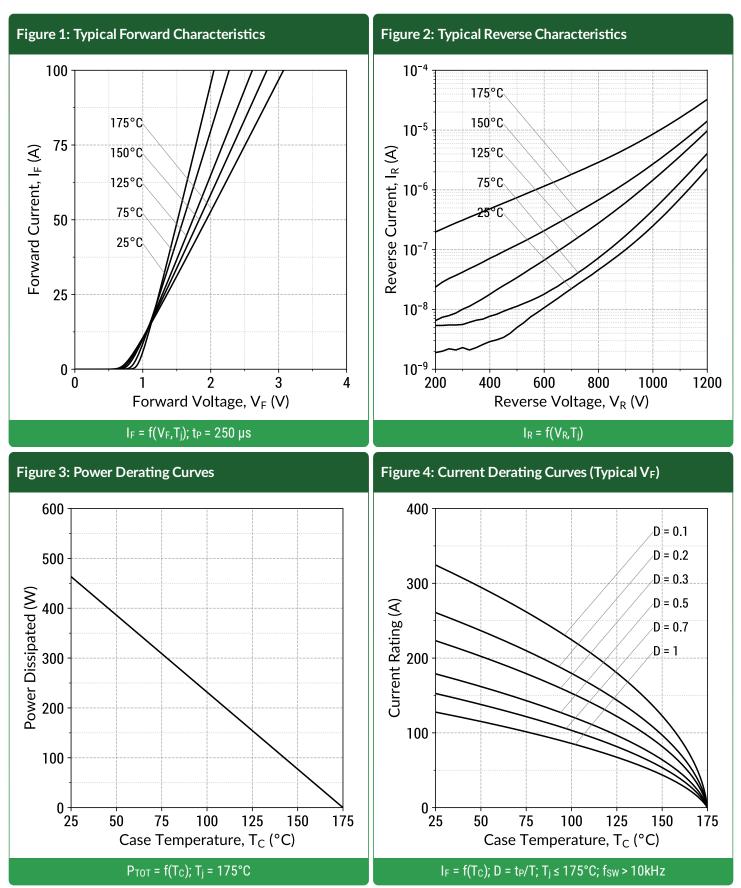
Electrical Characteristics

Parameter	Symbol	Conditions -		Values		11	Note	
Parameter	Symbol			Min.	Тур.	Max.	Unit	Note
Diada Farward Valtaga	VF	I _F = 50 A, T _j = 25°C			1.5	1.8	V	Fig. 1
Diode Forward Voltage	VF	I _F = 50 A, T _j = 175°C			1.9			
Reverse Current		V _R = 1200 V, T _j = 25°C V _R = 1200 V, T _j = 175°C		3	30		Fig. 0	
	IR				33	μΑ	μA	Fig. 2
Total Capacitive Charge	0		V _R = 400 V		111		nC	Fig. 7
	Qc	I _F ≤ I _{F,MAX}	V _R = 800 V		162			
Switching Time	•	dI _F /dt = 200 A/µs V _R = 400 V		. 10				
	ts	V _R = 800 V			< 10		ns	
Tatal Canaditanaa	0	V _R = 1 V, f =	1MHz		1842		<u>م</u> ۲	
Total Capacitance	С	V _R = 800 V, f = 1MHz			108		pF	Fig. 6

Thermal/Package Characteristics

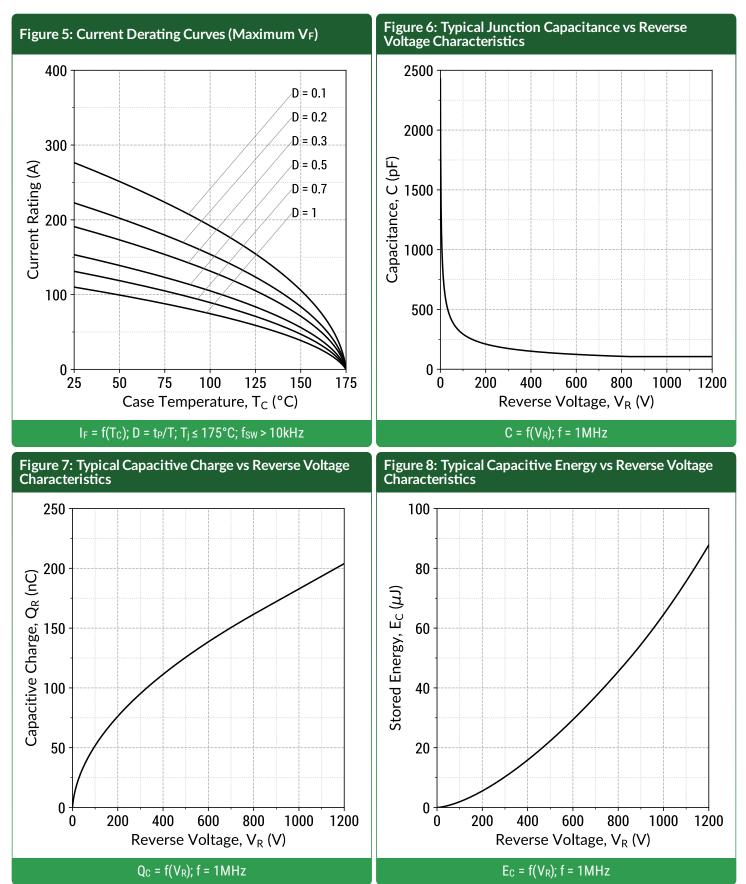
Deremeter	Symbol	Symbol Conditions Values				11	Note
Parameter	Symbol	Conditions	Min.	n. Typ. Max.	Unit	Note	
Thermal Resistance, Junction - Case	RthJC			0.32		°C/W	Fig. 9
Weight	WT			6.0		g	
Mounting Torque	Тм	Screws to Heatsink			1.1	Nm	





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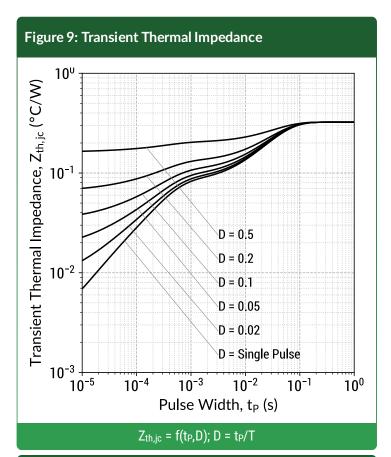


Figure 10: Forward Curve Model

 $I_F = f(V_F, T_j)$

Forward Curve Model Equation:

 $I_{F} = (V_{F} - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

 $V_{BI}(T_j) = m \times T_j + n (V)$ m = -0.00119 (V/°C) n = 1.01 (V)

Differential Resistance (RDIFF):

 $\begin{aligned} & \mathsf{R}_{\mathsf{DIFF}}(\mathsf{T}_{j}) = \mathbf{a} \times \mathsf{T}_{j}^{2} + \mathbf{b} \times \mathsf{T}_{j} + \mathbf{c} \, (\Omega) \\ & \mathbf{a} = 2.37\text{e-}07 \, (\Omega/^{\circ}\text{C}^{2}) \\ & \mathbf{b} = 3.29\text{e-}05 \, (\Omega/^{\circ}\text{C}) \\ & \mathbf{c} = 0.00976 \, (\Omega) \end{aligned}$

Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$

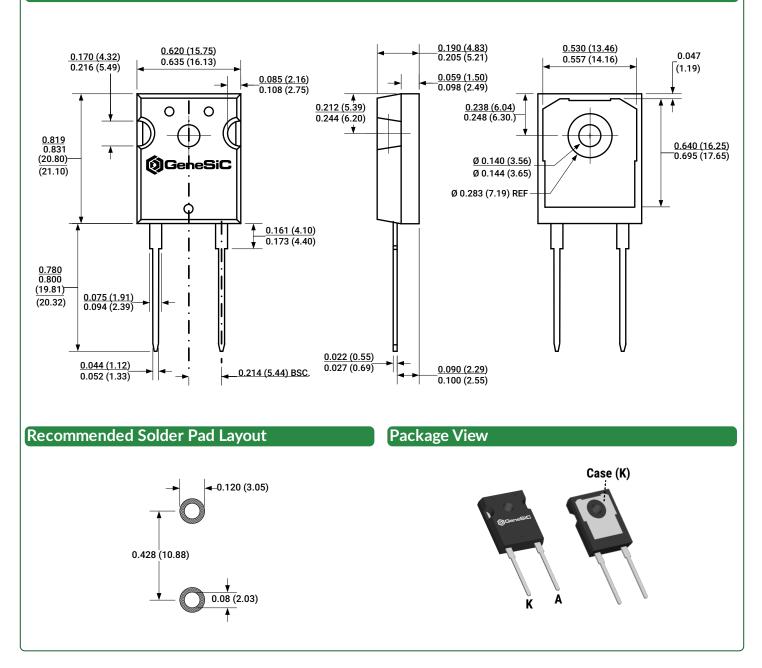


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Package Dimensions

TO-247-2 Package Outline



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.

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Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

SPICE Models:	https://www.genesicsemi.c	com/sic-schottky-mps/GD50MP	S12H/GD50MPS12H_SPICE.zip

- PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GD50MPS12H/GD50MPS12H_PLECS.zip
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- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

Revision History

- Rev 21/Jul: Updated with most recent test data
- Supersedes: Rev 20/Jul



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